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April 2004

FDW2510NZ

FDW2510NZ

FAIRCHILD SEMICONDUCTOR®

Dual N-Channel 2.5V Specified PowerTrench[®] MOSFET

General Description

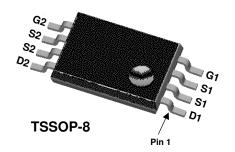
This N-Channel 2.5V specified MOSFET is a rugged gate version of Fairchild's Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V - 12V).

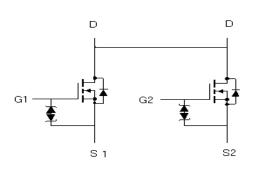
Applications

• Li-Ion Battery Pack

Features

- 6.4 A, 20 V $R_{DS(ON)} = 24 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$ $R_{DS(ON)} = 32 \text{ m}\Omega @ V_{GS} = 2.5 \text{ V}$
- Extended V_{GSS} range (±12V) for battery applications
- ESD protection diode (note 3)
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- Low profile TSSOP-8 package





Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DSS}	Drain-Sour	Source Voltage		20	V
V _{GSS}	Gate-Source Voltage			±12	V
ID	Drain Current – Continuous (Note 1a)		(Note 1a)	6.4	А
		– Pulsed	30		
P _D Power Dissipa		ipation for Single Operation	(Note 1a)	1.6	W
			(Note 1b)	1.1	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	
Therma	l Charac	teristics			
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)			77	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction-to-Ambient (Note 1b)			114	
Packag	e Markin	g and Ordering In	formation		
Device Marking		Device	Reel Size	Tape width	Quantity
	0NZ	FDW2510NZ	13"	12mm	3000 units

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	racteristics		1			
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 250 \mu A$	20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25° C		15		mV/°C
IDSS	Zero Gate Voltage Drain Current	$V_{DS} = 16 V$, $V_{GS} = 0 V$			1	μA
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μA
On Char	acteristics (Note 2)			•		•
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \ \mu A$	0.6	0.98	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		-0.4		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$ \begin{array}{l} V_{GS} = 4.5 \ V, & I_D = 6.4 \ A \\ V_{GS} = 4V, & I_D = 6.1 \ A \\ V_{GS} = 3.1 \ V, & I_D = 5.8 \ A \\ V_{GS} = 2.5 \ V, & I_D = 5.6 \ A \\ V_{GS} = 4.5 \ V, & I_D = 6.4 \ A, \ T_J = 125^\circ C \end{array} $		18 19 21 25 26	24 25 28 32 37	mΩ
g FS	Forward Transconductance	$V_{DS} = 5 V$, $I_{D} = 6.4 A$		28		S
Dynamic	c Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$		870		pF
Coss	Output Capacitance	f = 1.0 MHz		225		pF
C _{rss}	Reverse Transfer Capacitance	-		125		pF
R _G	Gate Resistance	$V_{GS} = 15 \text{ mV}, \text{ f} = 1.0 \text{ MHz}$		1.9		Ω
Switchir	ng Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 10 V, \qquad I_{D} = 1 A,$		9	18	ns
t _r	Turn–On Rise Time	$V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		13	23	ns
t _{d(off)}	Turn-Off Delay Time			18	33	ns
t _f	Turn–Off Fall Time	7		9	18	ns
Qg	Total Gate Charge	$V_{DS} = 10 V$, $I_{D} = 6.4 A$,		8.2	12	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 4.5 V$		1.8		nC
Q _{gd}	Gate-Drain Charge			2.3		nC

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LIECUIN	cal Characteristics	$T_A = 25^{\circ}C$ unless otherwise noted	-			
Symbol	Parameter	Parameter Test Conditions		Тур	Max	Units
Drain-S	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain–Source Diode Forward Current				1.3	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \ V, I_S = 1.3 \ A (Note 2)$		0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 6.4 A		18		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A}/\mu \text{s} \qquad (\text{Note 2})$		6		nC

Notes:

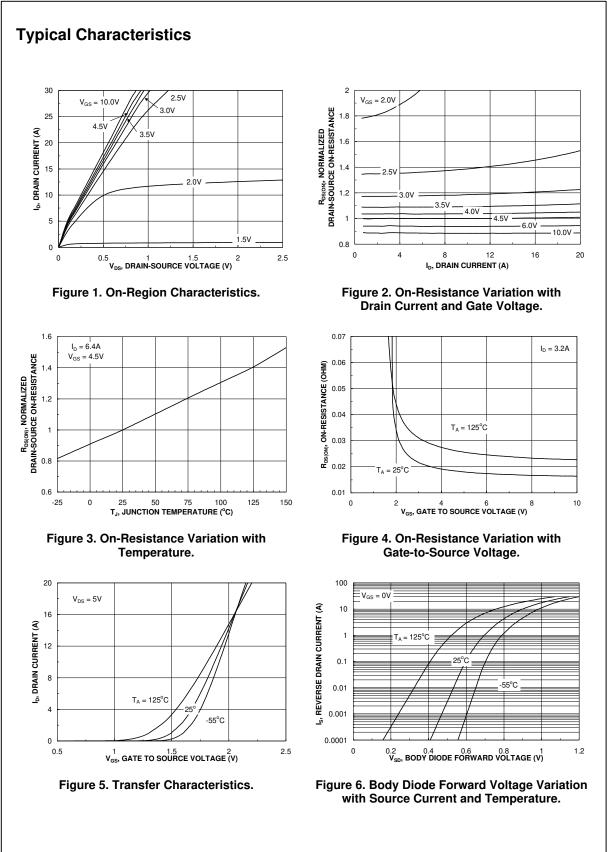
1. R_{6JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $\rm R_{BJC}$ is guaranteed by design while $\rm R_{BCA}$ is determined by the user's board design.

a) R_{eJA} is 77°C/W (steady state) when mounted on a 1 inch² copper pad on FR-4.
b) R_{eJA} is 114 °C/W (steady state) when mounted on a minimum copper pad on FR-4.

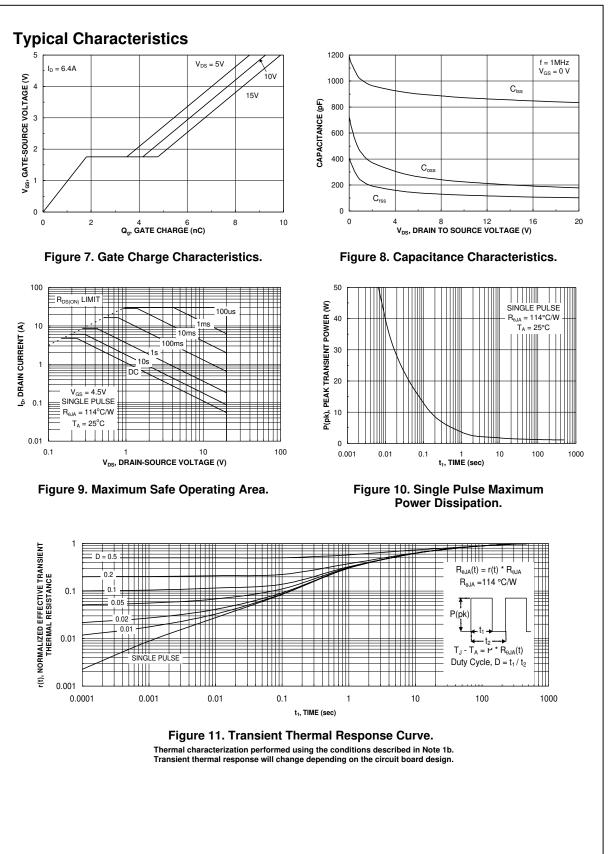
2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty Cycle < 2.0%

3. The diode connected between the gate and source serves only as protection against ESD. No gate over voltage rating is implied.

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